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# STGW40NC60WD

# 40 A - 600 V - ultra fast IGBT

### **Features**

- Low C<sub>RES</sub> / C<sub>IES</sub> ratio (no cross conduction susceptibility)
- IGBT co-packaged with ultra fast free-wheeling diode
- High frequency operation

## **Applications**

- High frequency inverters, UPS
- Motor drivers
- HF, SMPS and PFC in both hard switch and resonant topologies
- Welding
- Induction heating

## Description

This IGBT utilizes the advanced PowerMESH™ process resulting in an excellent trade-off between switching performance and low on-state behavior. )050lete

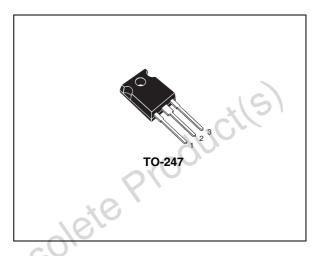
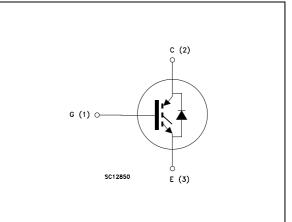


Figure 1.

Internal schematic diagram



Order code	Marking	Package	Packaging
STGW40NC60WD	GW40NC60WD	TO-247	Tube

# Contents

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0105	Electrical ratings



### 1

# **Electrical ratings**

Table 2.	Absolute	maximum	ratings
	Aboult	maximum	runngo

Symbol	Parameter	Value	Unit
V <sub>CES</sub>	Collector-emitter voltage ( $V_{GE} = 0$ )	600	V
I <sub>C</sub> <sup>(1)</sup>	Collector current (continuous) at 25 °C	70	А
I <sub>C</sub> <sup>(1)</sup>	Collector current (continuous) at 100 °C	40	Α
I <sub>CL</sub> <sup>(2)</sup>	Turn-off latching current	230	А
I <sub>CP</sub> <sup>(3)</sup>	Pulsed collector current	230	А
$V_{GE}$	Gate-emitter voltage	±20	V
١ <sub>F</sub>	Diode RMS forward current at $T_{C}$ =25 °C	30	А
I <sub>FSM</sub>	Surge non repetitive forward current (tp=10 ms sinusoidal)	120	A
P <sub>TOT</sub>	Total dissipation at $T_C = 25 \ ^{\circ}C$	250	W
Тj	Operating junction temperature	– 55 to 150	°C

1. Calculated according to the iterative formula:

$$I_{C}(T_{C}) = \frac{T_{JMAX} - T_{C}}{R_{THJ-C} \times V_{CESAT(MAX)}(T_{C}, I_{C})}$$

2. Vclamp = 80%(V\_{CES}), Tj = 150 °C, R\_G = 10  $\Omega,$  V\_{GE}= 15 V

3. Pulse width limited by max. junction temperature allowed

Table 3. Thermal resistance

	Symbol	Parameter	Value	Unit
	R <sub>thj-case</sub>	Thermal resistance junction-case max (IGBT)	0.5	°C/W
10	R <sub>thj-case</sub>	Thermal resistance junction-case max (diode)	1.5	°C/W
SO'	R <sub>thj-amb</sub>	Thermal resistance junction-ambient max	50	°C/W
000				



#### **Electrical characteristics** 2

(T<sub>CASE</sub>=25 °C unless otherwise specified)

Table 4.	Static
	olulio

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)CES</sub>	Collector-emitter breakdown voltage (V <sub>GE</sub> = 0)	I <sub>C</sub> = 1 mA	600			v
V <sub>CE(sat)</sub>	Collector-emitter saturation voltage	V <sub>GE</sub> = 15 V, I <sub>C</sub> = 30 A V <sub>GE</sub> = 15 V, I <sub>C</sub> = 30 A, T <sub>C</sub> =125 °C		2.1 1.9	2.5	v v
V <sub>GE(th)</sub>	Gate threshold voltage	$V_{CE} = V_{GE}$ , $I_C = 250 \mu A$	3.75	X	5.75	V
I <sub>CES</sub>	Collector-emitter cut-off current (V <sub>GE</sub> = 0)	V <sub>GE</sub> = 600 V V <sub>GE</sub> = 600 V, T <sub>C</sub> =125 °C	6	70	500 5	μA mA
I <sub>GES</sub>	Gate-emitter cut-off current (V <sub>CE</sub> = 0)	V <sub>GE</sub> = ± 20 V			±100	nA
9 <sub>fs</sub>	Forward transconductance	$V_{CE} = 15 V_{,} I_{C} = 30 A$		20		S

#### Table 5. Dynamic

	9 <sub>fs</sub>	Forward transconductance	$V_{CE} = 15 V_{,} I_{C} = 30 A$		20		5
	Table 5. Symbol	Dynamic Parameter	Test conditions	Min.	Тур.	Max.	Unit
	C <sub>ies</sub> C <sub>oes</sub> C <sub>res</sub>	Input capacitance Output capacitance Reverse transfer capacitance	V <sub>CE</sub> = 25 V, f = 1 MHz, V <sub>GE</sub> = 0		2900 298 59		pF pF pF
	Q <sub>g</sub> Q <sub>ge</sub> Q <sub>gc</sub>	Total gate charge Gate-emitter charge Gate-collector charge	$V_{CE} = 390 \text{ V}, I_C = 30 \text{ A},$ $V_{GE} = 15 \text{ V}$ (see Figure 18)		126 16 46		nC nC nC
Obsole	7	<u>.</u>	·				

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub> (di/dt) <sub>on</sub>	Turn-on delay time Current rise time Turn-on current slope	$V_{CC} = 390 \text{ V}, I_C = 30 \text{ A}$ $R_G = 10 \Omega, V_{GE} = 15 \text{ V}$ (see Figure 17)		33 12 2600		ns ns A/µs
t <sub>d(on)</sub> t <sub>r</sub> (di/dt) <sub>on</sub>	Turn-on delay timE Current rise time Turn-on current slope	$V_{CC} = 390 \text{ V}, I_C = 30 \text{ A}$ $R_G = 10 \Omega, V_{GE} = 15 \text{ V},$ $T_C = 125 \text{ °C}$ <i>(see Figure 17)</i>		32 14 2300		ns ns A/µs
t <sub>r</sub> (V <sub>off</sub> ) t <sub>d</sub> ( <sub>off</sub> ) t <sub>f</sub>	Off voltage rise time Turn-off delay time Current fall time	$V_{CC} = 390 \text{ V}, I_C = 30 \text{ A},$ $R_{GE} = 10 \Omega, V_{GE} = 15 \text{ V}$ (see Figure 17)		26 168 36	L'S	ns ns ns
t <sub>r</sub> (V <sub>off</sub> ) t <sub>d</sub> ( <sub>off</sub> ) t <sub>f</sub>	Off voltage rise time Turn-off delay time Current fall time	$\begin{split} V_{CC} &= 390 \text{ V}, \text{ I}_{C} = 30 \text{ A}, \\ R_{GE} &= 10 \Omega, \text{ V}_{GE} = 15 \text{ V}, \\ T_{C} &= 125 \text{ °C} \text{ (see Figure 17)} \end{split}$	0	54 213 67		ns ns ns

Table 6. Switching on/off (inductive load)

### Table 7. Switching energy (inductive load)

Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
E <sub>on</sub> <sup>(1)</sup> E <sub>off</sub> <sup>(2)</sup> E <sub>ts</sub>	Turn-on switching losses Turn-off switching losses Total switching losses	$V_{CC} = 390 \text{ V}, I_C = 30 \text{ A}$ $R_G = 10 \Omega, V_{GE} = 15 \text{ V}$ (see Figure 17)		302 349 651		μJ μJ μJ
E <sub>on</sub> <sup>(1)</sup> E <sub>off</sub> <sup>(2)</sup> E <sub>ts</sub>	Turn-on switching losses Turn-off switching losses Total switching losses	$V_{CC} = 390 \text{ V}, I_C = 30 \text{ A}$ $R_G = 10 \Omega, V_{GE} = 15 \text{ V},$ $T_C = 125 \text{ °C}$ (see Figure 17)		553 750 1303		μJ μJ μJ

1. Eon is the turn-on losses when a typical diode is used in the test circuit in figure 2 Eon include diode recovery energy. If the IGBT is offered in a package with a co-pak diode, the co-pack diode is used as external diode. IGBTs & Diode are at the same temperature (25 °C and 125 °C)

2. Turn-off losses include also the tail of the collector current



Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
V <sub>F</sub>	Forward on-voltage	I <sub>F</sub> = 30 A I <sub>F</sub> = 30 A, T <sub>C</sub> = 125 °C		2.4 1.8		V V
t <sub>rr</sub> Q <sub>rr</sub>	Reverse recovery time Reverse recovery charge	I <sub>F</sub> = 30 A, V <sub>R</sub> = 50 V, di/dt =100 A/μs		45 56		ns nC
I <sub>rrm</sub> t <sub>rr</sub> Q <sub>rr</sub> I <sub>rrm</sub>	Reverse recovery current Reverse recovery time Reverse recovery charge Reverse recovery current	$(see \ Figure \ 20) \\ I_F = 30 \ A, \ V_R = 50 \ V, \\ T_C = 125 \ ^\circ C, \\ di/dt = 100 \ A/\mu s \\ (see \ Figure \ 20) \ 20) \ (see \ 20) \ 20) \ 20) \ (see \ 20) \ 20) \ (see \ 20) \ 20) \ 20) \ 20) \ 20) \ 20) \ 20) \ 20) \ 20) \ 20) \ 20) \ 20) \ 20) \ 20) \ 20) \ 20) \ $		2.55 100 290 5.8	19	A ns nC A
		P				
		oletei				
	Ć	josu				
	ct(S)					
	7170					
0	$(0^{0,0})$					
lete P	$(0^{0,0})$					
lete P	(00.0					
leteP	Reverse recovery current					

 Table 8.
 Collector-emitter diode



HV31645

12 VGE(V)

150 TJ (°C)

100

50

#### **Electrical characteristics (curves)** 2.1

#### Figure 2. **Output characteristics**

**Transfer characteristics** Figure 3.

lc(A)

200

150

100

50

0

1.6

-50

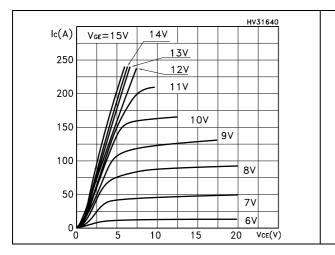




Figure 5.

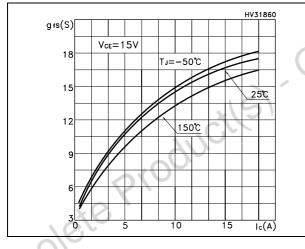


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3

9

 $V_{CE} = 15V$ 



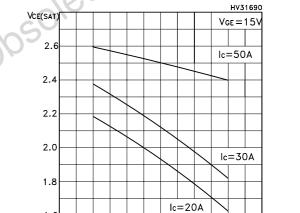
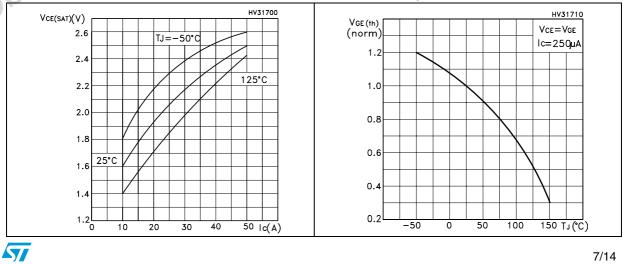


Figure 6.

Collector-emitter on voltage vs collector current

Figure 7. Normalized gate threshold vs temperature



HV31630

#### Figure 8. Normalized breakdown voltage vs Figure 9. temperature

VGE(V)

15

12

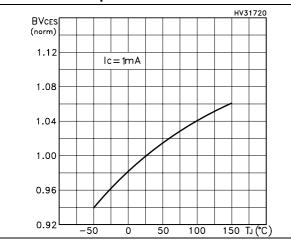
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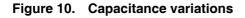
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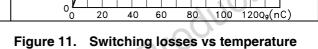
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Vce=390V

lc=30A







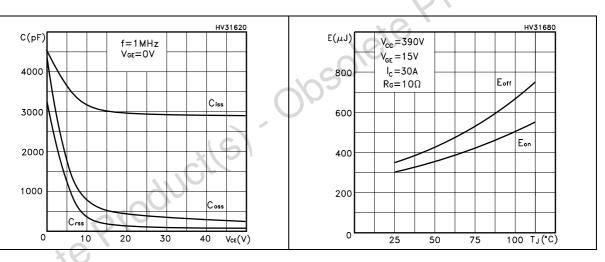
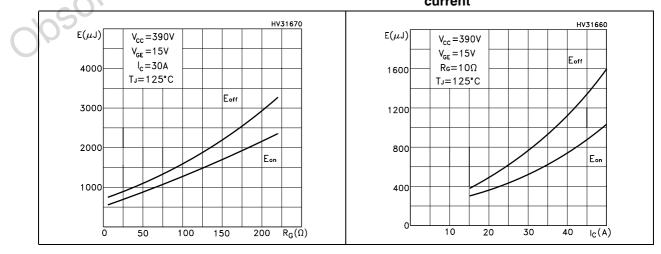


Figure 12. Switching losses vs gate resistance Figure 13. Switching losses vs collector current



### Gate charge vs gate-emitter voltage

### Figure 14. Thermal impedance

### Figure 15. Turn-off SOA

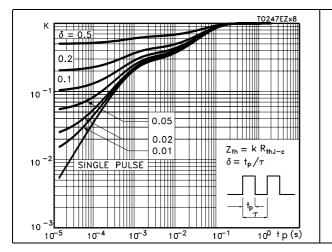
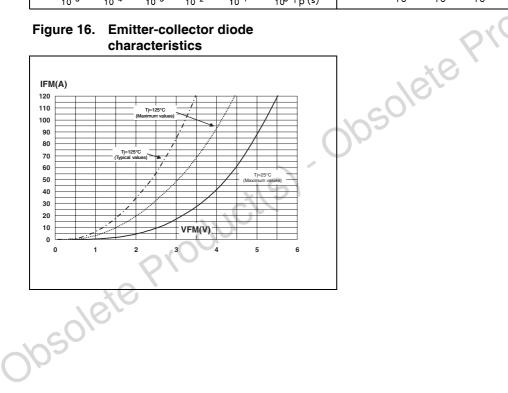
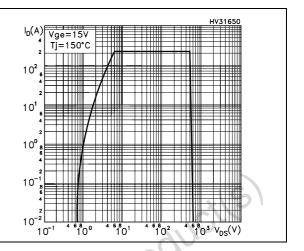


Figure 16. Emitter-collector diode characteristics





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# 3 Test circuit

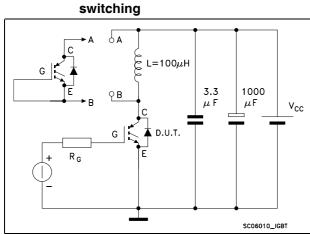


Figure 17. Test circuit for inductive load

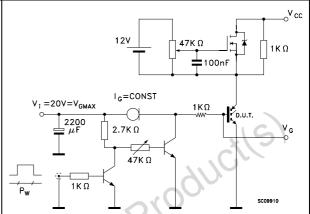
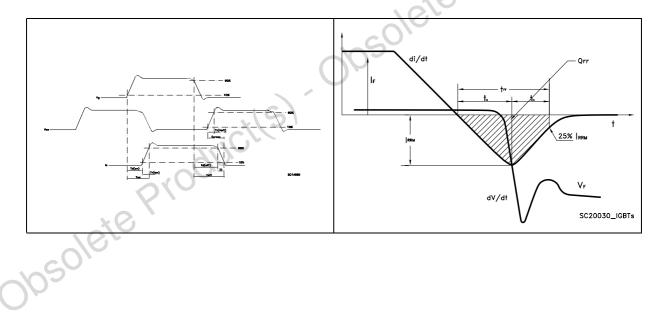


Figure 19. Switching waveforms





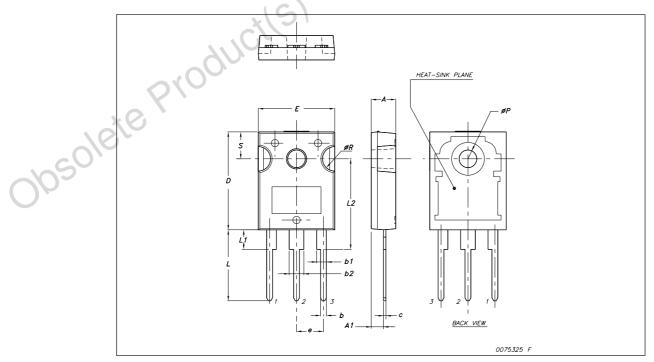
### 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: *www.st.com* 

Obsolete Produci(s) - Obsolete Produci(s)

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TO-247 mechanical data					
Dim.	mm.				
Dini.	Min.	Тур	Max.		
А	4.85		5.15		
A1	2.20		2.60		
b	1.0		1.40		
b1	2.0		2.40		
b2	3.0		3.40		
с	0.40		0.80		
D	19.85		20.15		
E	15.45		15.75		
e		5.45	$\langle O \rangle$		
L	14.20		14.80		
L1	3.70		4.30		
L2		18.50			
øP	3.55	5	3.65		
øR	4.50	)V	5.50		
S		5.50			



# 5 Revision history

### Table 9. Document revision history

	Date	Revision	Changes	
	8-Jun-2006	1	First release	
	08-Nov-2006	2	Modified <i>Dynamic</i>	
	01-Feb-2008	3	Updated Table 7	
	09-Jul-2008	4	Added new feature	
obsolete Production				



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